

Search Notes

Application/Control No.

10/667,598

Examiner

Richard K. Lee

Applicant(s)/Patent under
Reexamination

NAKAZAWA ET AL.

Art Unit

2832

SEARCHED

Class	Subclass	Date	Examiner
200	16R	1/24/2004	KL
	16A		
	549		
	550		
	275		
	252		
	280		
200	557	1/24/2004	KL
Search	updated.	3/16/2005	KL

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Same as	above.	3/16/2005	KL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR